

**Search Notes**

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Examiner

Hai C. Pham

Applicant(s)/Patent under  
Reexamination

ONO ET AL.

Art Unit

2861

**SEARCHED**

Class	Subclass	Date	Examiner
347	19, 228, 236-237, 246-247	6/23/2006	HP
399	15, 53	6/23/2006	HP
	59-60		
396	564	6/23/2006	HP

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST Text Search	6/23/2006	HP